


<b>Search Notes</b> 	<b>Application/Control No.</b> 10530656	<b>Applicant(s)/Patent Under Reexamination</b> MEHR ET AL.
	<b>Examiner</b> HUYEN D LE	<b>Art Unit</b> 2615

SEARCHED			
Class	Subclass	Date	Examiner
381	312, 322, 324, 328, 330	4/12/08	HL
174	33, 34, 250, 261	4/12/08	HL
439	77	4/12/08	HL
361	749	4/12/08	HL
Updated Search	Same as above	11/18/08	HL
Updated Search	Same as above	3/26/09	HL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/HUYEN D LE/ Primary Examiner.Art Unit 2614
--	------------------------------------------------